

### General Description

- Latest Trench Power AlphaMOS (αMOS LV) technology
- Very Low RDS(on) at 4.5V<sub>GS</sub>
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

### Application

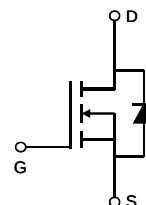
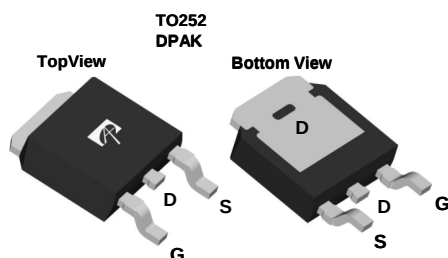
- DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial

### Product Summary

|                                                 |         |
|-------------------------------------------------|---------|
| V <sub>DS</sub>                                 | 30V     |
| I <sub>D</sub> (at V <sub>GS</sub> =10V)        | 70A     |
| R <sub>DS(ON)</sub> (at V <sub>GS</sub> =10V)   | < 2.4mΩ |
| R <sub>DS(ON)</sub> (at V <sub>GS</sub> = 4.5V) | < 3.2mΩ |

100% UIS Tested

100% R<sub>g</sub> Tested



### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

| Parameter                              | Symbol                            | Maximum    | Units |
|----------------------------------------|-----------------------------------|------------|-------|
| Drain-Source Voltage                   | V <sub>DS</sub>                   | 30         | V     |
| Gate-Source Voltage                    | V <sub>GS</sub>                   | ±20        | V     |
| Continuous Drain Current <sup>G</sup>  | I <sub>D</sub>                    | 70         | A     |
|                                        |                                   | 55         |       |
| Pulsed Drain Current <sup>C</sup>      | I <sub>DM</sub>                   | 280        |       |
| Continuous Drain Current               | I <sub>DSM</sub>                  | 27         | A     |
|                                        |                                   | 22         |       |
| Avalanche Current <sup>C</sup>         | I <sub>AS</sub>                   | 55         | A     |
| Avalanche energy L=0.1mH <sup>C</sup>  | E <sub>AS</sub>                   | 151        | mJ    |
| V <sub>DS</sub> Spike                  | V <sub>SPIKE</sub>                | 36         | V     |
| Power Dissipation <sup>B</sup>         | P <sub>D</sub>                    | 83         | W     |
|                                        |                                   | 33         |       |
| Power Dissipation <sup>A</sup>         | P <sub>DSM</sub>                  | 2.5        | W     |
|                                        |                                   | 1.6        |       |
| Junction and Storage Temperature Range | T <sub>J</sub> , T <sub>STG</sub> | -55 to 175 | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol           | Typ | Max | Units |
|--------------------------------------------|------------------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup>   | R <sub>θJA</sub> | 16  | 20  | °C/W  |
| Maximum Junction-to-Ambient <sup>A D</sup> |                  | 41  | 50  | °C/W  |
| Maximum Junction-to-Case                   | R <sub>θJC</sub> | 0.8 | 1.5 | °C/W  |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                                          | Conditions                                                                                 | Min | Typ      | Max      | Units |
|-----------------------------|----------------------------------------------------|--------------------------------------------------------------------------------------------|-----|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                                    |                                                                                            |     |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                 | 30  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |     |          | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V                                                |     |          | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                   | 1   | 1.5      | 2        | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |     | 2<br>2.5 | 2.4<br>3 | mΩ    |
|                             |                                                    | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A                                                 |     | 2.5      | 3.2      | mΩ    |
|                             |                                                    |                                                                                            |     |          |          |       |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                   |     | 85       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                    |     | 0.7      | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>6</sup> |                                                                                            |     |          | 70       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                                    |                                                                                            |     |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                          |     | 3430     |          | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |                                                                                            |     | 1327     |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                       |                                                                                            |     | 175      |          | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                           | 0.3 | 0.7      | 1.1      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                                    |                                                                                            |     |          |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            |     | 53       | 64       | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                                  |                                                                                            |     | 25       | 30       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |                                                                                            |     | 7.8      |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |                                                                                            |     | 10.3     |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |     | 7.5      |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |                                                                                            |     | 5.0      |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |                                                                                            |     | 33.8     |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |                                                                                            |     | 9.8      |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =20A, dI/dt=500A/μs                                                         |     | 22       |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =20A, dI/dt=500A/μs                                                         |     | 58       |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

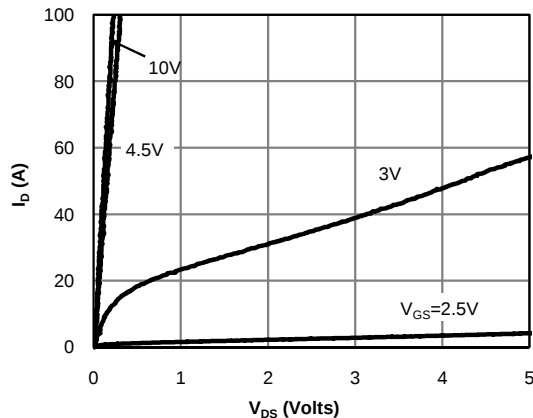


Figure 1: On-Region Characteristics (Note E)

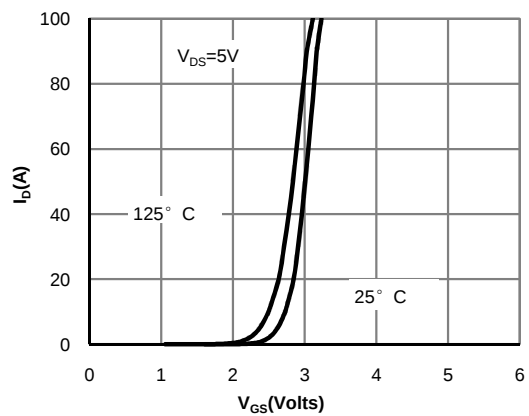


Figure 2: Transfer Characteristics (Note E)

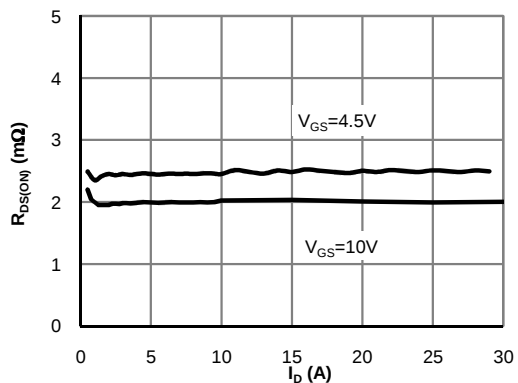


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

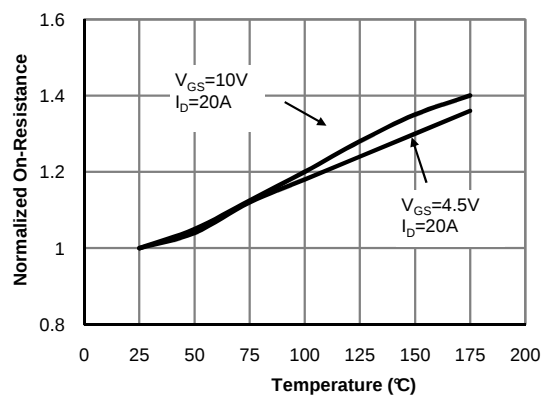


Figure 4: On-Resistance vs. Junction Temperature (Note E)

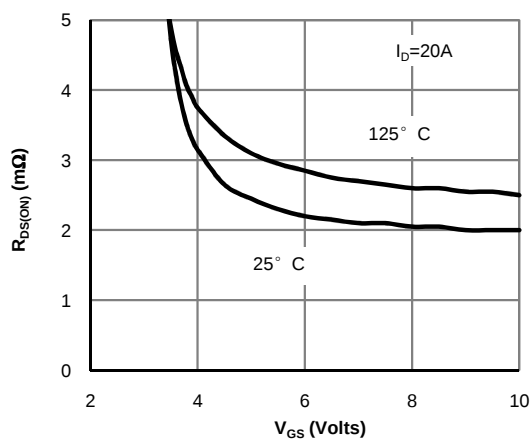


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

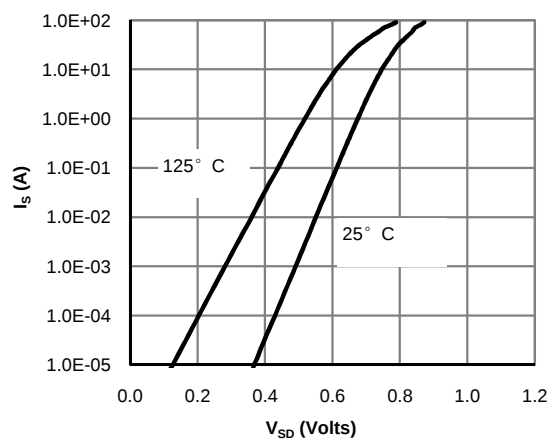
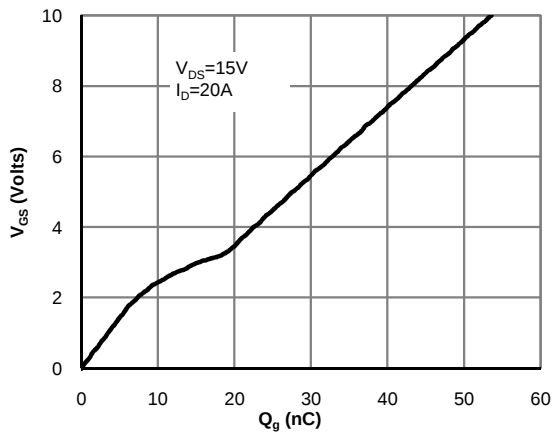
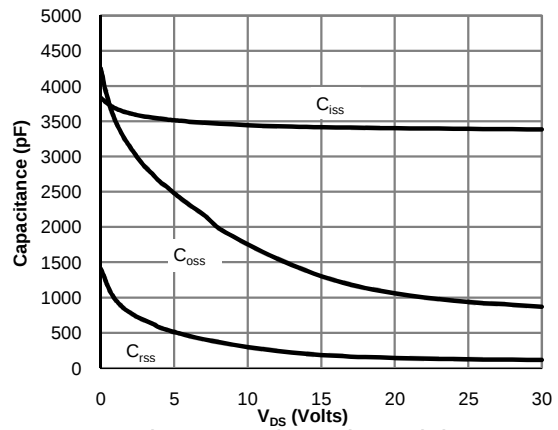


Figure 6: Body-Diode Characteristics (Note E)

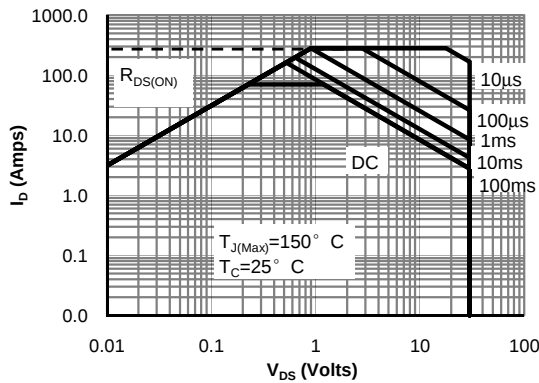
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



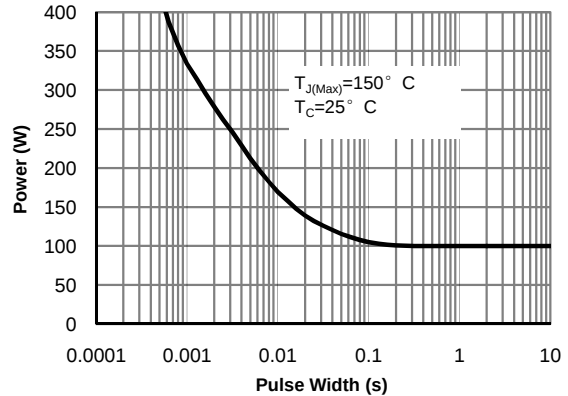
**Figure 7: Gate-Charge Characteristics**



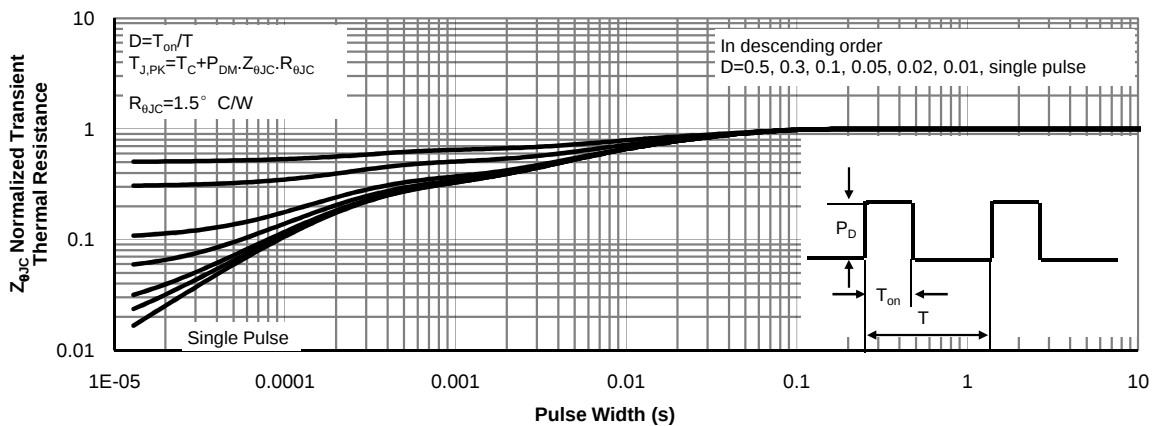
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

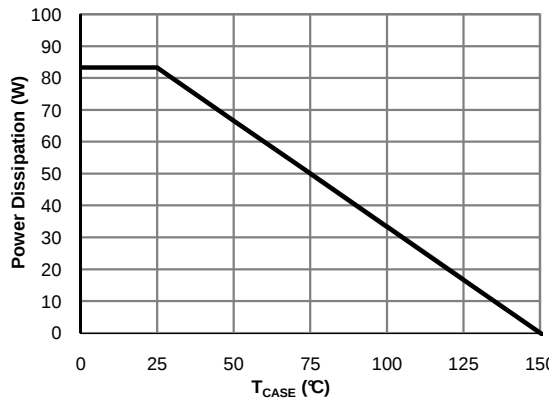


Figure 12: Power De-rating (Note F)

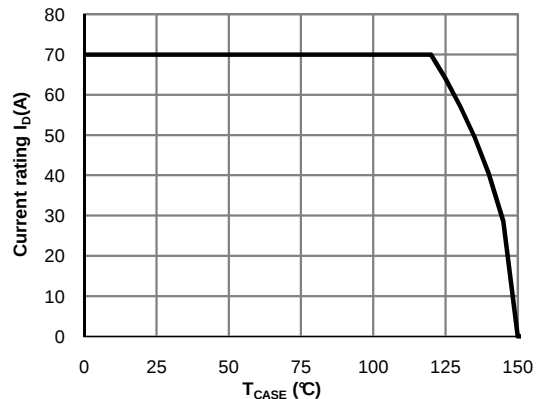


Figure 13: Current De-rating (Note F)

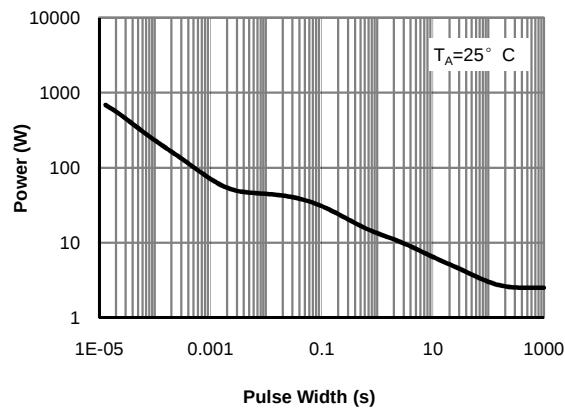


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

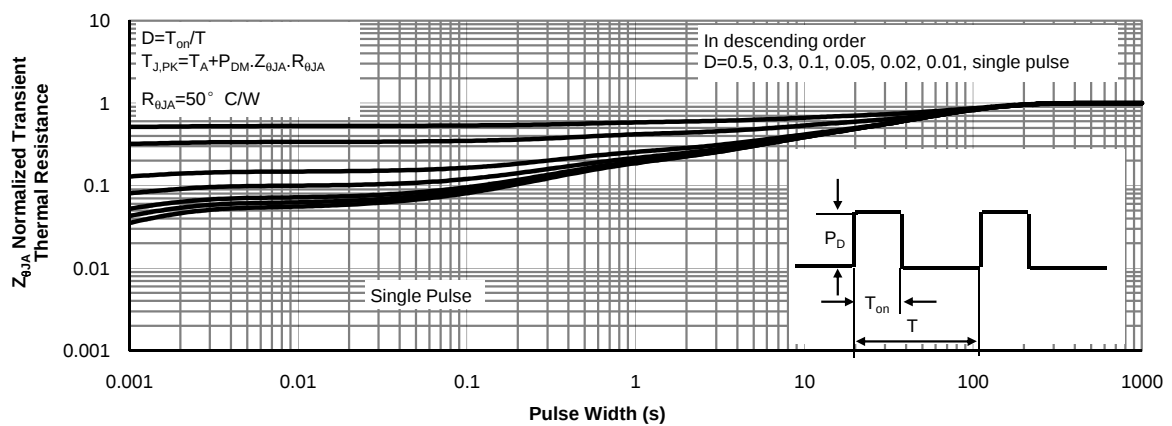
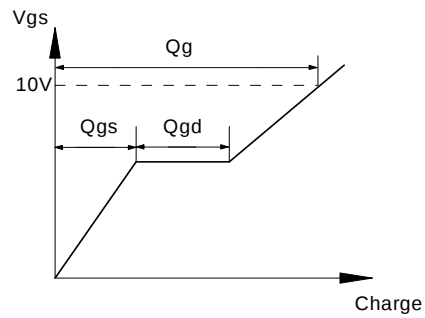
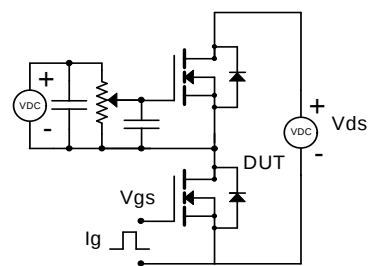
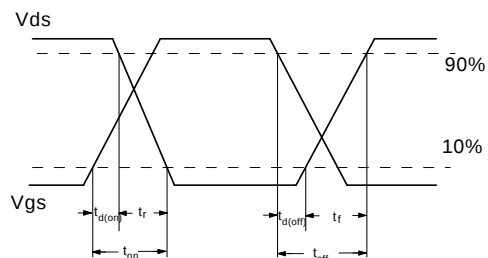
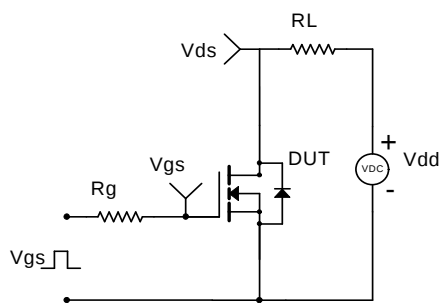


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

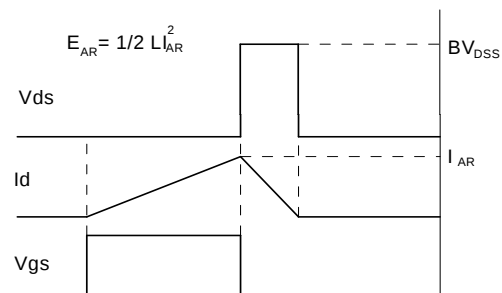
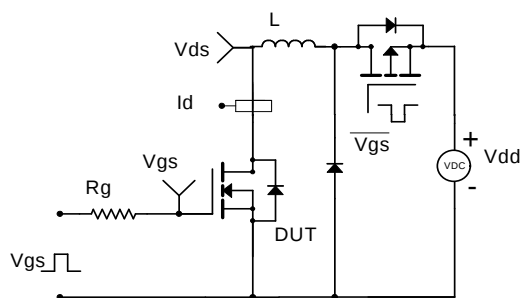
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

